

## Notice of References Cited

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Examiner	Art Unit	
Jean B Fleurantin	2172	Page 1 of 1

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## **NON-PATENT DOCUMENTS**

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.